

isc Silicon NPN Power Transistor

MJE200

DESCRIPTION

- Low Collector-Emitter Saturation Voltage
- DC Current Gain-Bandwidth Product
- High DC Current Gain
- Complement to MJE210

APPLICATIONS

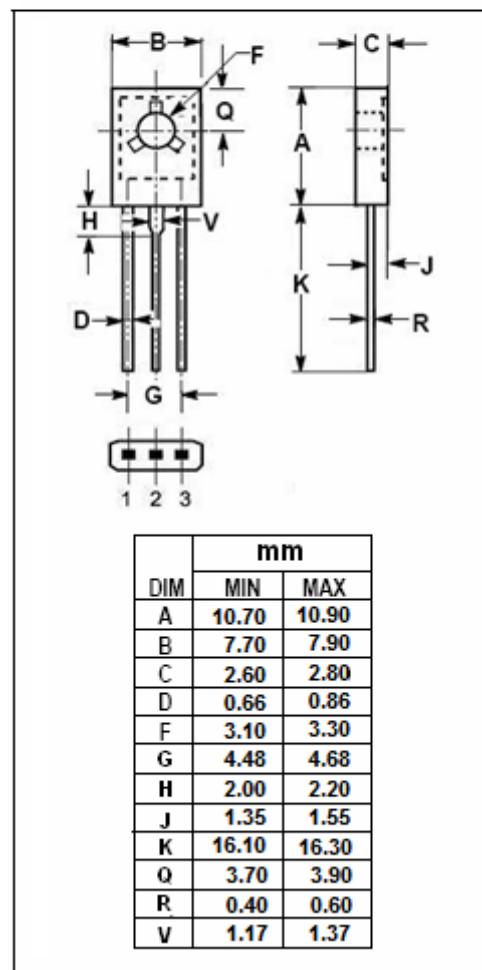
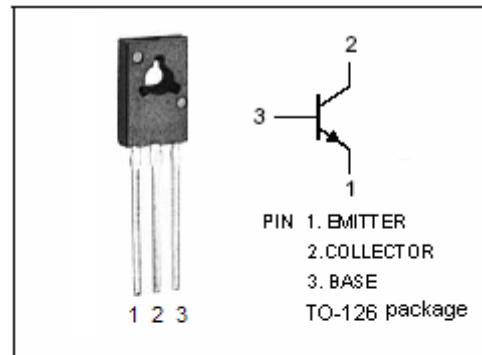
- Designed for low voltage, low-power, high-gain audio amplifier applications.

ABSOLUTE MAXIMUM RATINGS($T_a=25^\circ\text{C}$)

SYMBOL	PARAMETER	VALUE	UNIT
V_{CBO}	Collector-Base Voltage	40	V
V_{CEO}	Collector-Emitter Voltage	25	V
V_{EBO}	Emitter-Base Voltage	8	V
I_c	Collector Current-Continuous	5	A
I_B	Base Current	1	A
P_c	Collector Power Dissipation $T_c=25^\circ\text{C}$	15	W
T_j	Junction Temperature	150	$^\circ\text{C}$
T_{stg}	Storage Temperature Range	-65~150	$^\circ\text{C}$

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	MAX	UNIT
$R_{th j-c}$	Thermal Resistance,Junction to Case	8.34	$^\circ\text{C}/\text{W}$
$R_{th j-a}$	Thermal Resistance,Junction to Ambient	83.4	$^\circ\text{C}/\text{W}$



isc Silicon NPN Power Transistor**MJE200****ELECTRICAL CHARACTERISTICS****T_c =25°C unless otherwise specified**

SYMBOL	PARAMETER	CONDITIONS	MIN	MAX	UNIT
V _{CEO(SUS)}	Collector-Emitter Sustaining Voltage	I _C = 10mA; I _B = 0	25		V
V _{CE(sat)-1}	Collector-Emitter Saturation Voltage	I _C = 0.5 A ;I _B = 50mA		0.3	V
V _{CE(sat)-2}	Collector-Emitter Saturation Voltage	I _C = 2A ;I _B = 0.2A		0.75	V
V _{CE(sat)-3}	Collector-Emitter Saturation Voltage	I _C =5A ;I _B =1A		1.8	V
V _{BE(sat)}	Base-Emitter Saturation Voltage	I _C =5A ;I _B = 1A		2.5	V
V _{BE(on)}	Base-Emitter On Voltage	I _C = 2A; V _{CE} = 1V		1.6	V
I _{CBO}	Collector Cutoff Current	V _{CB} = 40V; I _E = 0 V _{CB} = 40V; I _E = 0;T _C = 125°C		0.1 0.1	µ A mA
I _{EBO}	Emitter Cutoff Current	V _{EB} = 8V; I _C = 0		0.1	µ A
h _{FE-1}	DC Current Gain	I _C = 0.5 A ; V _{CE} = 1V	70		
h _{FE-2}	DC Current Gain	I _C = 2A ; V _{CE} = 1V	45	180	
h _{FE-3}	DC Current Gain	I _C = 5A ; V _{CE} =2V	10		
f _T	Current-Gain—Bandwidth Product	I _C = 0.1 A; V _{CE} = 10V; f _{test} = 10MHz	65		MHz
C _{OB}	Collector Capacitance	I _E = 0; V _{CB} = 10V; f _{test} = 0.1MHz		80	pF